## MAX1082/MAX1083

## 300ksps/400ksps, Single-Supply, 4-Channel, Serial 10-Bit ADCs with Internal Reference

## General Description

The MAX1082/MAX1083 10-bit analog-to-digital converters (ADCs) combine a 4-channel analog-input multiplexer, high-bandwidth track/hold (T/H), and serial interface with high conversion speed and low power consumption. The MAX1082 operates from a single +4.5 V to +5.5 V supply; the MAX1083 operates from a single +2.7 V to +3.6 V supply. Both devices' analog inputs are software configurable for unipolar/bipolar and single-ended/pseudo-differential operation.
The 4-wire serial interface connects directly to SPI/QSPITM and MICROWIRE ${ }^{\circledR}$ devices without external logic. A serial strobe output allows direct connection to TMS320-family digital signal processors. The MAX1082/ MAX1083 use an external serial-interface clock to perform successiveapproximation analog-to-digital conversions. The devices feature an internal +2.5 V reference and a reference-buffer amplifier with a $\pm 1.5 \%$ voltage-adjustment range. An external reference with a 1 V to VDD range may also be used.
The MAX1082/MAX1083 provide a hard-wired $\overline{\text { SHDN }}$ pin and four software-selectable power modes (normal operation, reduced power (REDP), fast power-down (FASTPD), and full power-down (FULLPD)). These devices can be programmed to shut down automatically at the end of a conversion or to operate with reduced power. When using the power-down modes, accessing the serial interface automatically powers up the devices, and the quick turnon time allows them to be shut down between all conversions.
The MAX1082/MAX1083 are available in 16-pin TSSOP packages.

## Applications

Portable Data Logging
Data Acquisition
Medical Instruments
Battery-Powered Instruments
Pen Digitizers
Process Control

Typical Operating Circuit appears at end of data sheet.

QSPI is a trademark of Motorola, Inc.
MICROWIRE is a registered trademark of National Semiconductor Corp.

4-Channel Single-Ended or 2-Channel
Pseudo-Differential Inputs
Internal Multiplexer and Track/Hold
Single-Supply Operation
+4.5V to +5.5V (MAX1082)
+2.7V to +3.6V (MAX1083)
Internal +2.5V Reference
LookHz Sampling Rate (MAX1082)
Low Power: 2.5mA (400ksps)
1.3mA (REDP)
0.9mA (FASTPD)
2 4 A (FULLPD)
SPI/QSPI/MICROWIRE/TMS320-Compatible 4-Wire
Serial Interface

- Software-Configurable Unipolar or Bipolar Inputs
- 16-Pin TSSOP Package

Ordering Information

| PART | TEMP RANGE | PIN- <br> PACKAGE | INL <br> (LSB) |
| :--- | :---: | :---: | :---: |
| MAX1082ACUE + | $0^{\circ} \mathrm{C}$ to $+70^{\circ} \mathrm{C}$ | 16 TSSOP | $\pm 1 / 2$ |
| MAX1082BCUE + | $0^{\circ} \mathrm{C}$ to $+70^{\circ} \mathrm{C}$ | 16 TSSOP | $\pm 1$ |
| MAX1082AEUE + | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ | 16 TSSOP | $\pm 1 / 2$ |
| MAX1082BEUE + | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ | 16 TSSOP | $\pm 1$ |

+Denotes a lead(Pb)-free/RoHS-compliant package.
Ordering Information continued at end of data sheet.
Pin Configuration
TOP VIEW


## MAX1082/MAX1083

## 300ksps/400ksps, Single-Supply, 4-Channel, Serial 10-Bit ADCs with Internal Reference

## ABSOLUTE MAXIMUM RATINGS

| $V_{\text {DD_ }}$ to | 3V to +6 V |
| :---: | :---: |
| $\mathrm{V}_{\mathrm{DD}}{ }^{\text {- }}$ to $\mathrm{V}_{\mathrm{DD} 2}$ | -0.3V to +0.3V |
| CH0-CH3, COM to GND | -0.3V to ( $\left.\mathrm{V}_{\mathrm{DD}}+0.3 \mathrm{~V}\right)$ |
| REF, REFADJ to GND | -0.3V to (VDD +0.3 V ) |
| Digital Inputs to GND | -0.3V to +6V |
| Digital Outputs to GND | -0.3 V to ( $\left.\mathrm{V}_{\mathrm{DD}}+0.3 \mathrm{~V}\right)$ |
| Digital Output Sink Cur | ..................... 25 mA |



Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

## ELECTRICAL CHARACTERISTICS—MAX1082

$\left(\mathrm{V}_{\mathrm{DD} 1}=\mathrm{V}_{\mathrm{DD} 2}=+4.5 \mathrm{~V}\right.$ to $+5.5 \mathrm{~V}, \mathrm{COM}=\mathrm{GND}, \mathrm{fosc}=6.4 \mathrm{MHz}, 50 \%$ duty cycle, 16 clocks/conversion cycle (400ksps), external $+2.5 \mathrm{~V}$ at REF, REFADJ $=V_{D D 1}, T_{A}=T_{\text {MIN }}$ to $T_{M A X}$, unless otherwise noted. Typical values are at $T_{A}=+25^{\circ} \mathrm{C}$.)

| PARAMETER | SYMBOL | CONDITIONS | MIN TYP | MAX | UNITS |
| :---: | :---: | :---: | :---: | :---: | :---: |
| DC ACCURACY (Note 1) |  |  |  |  |  |
| Resolution |  |  | 10 |  | bits |
| Relative Accuracy (Note 2) | INL | MAX1082A |  | $\pm 0.5$ | LSB |
|  |  | MAX1083B |  | $\pm 1.0$ |  |
| Differential Nonlinearity | DNL | No missing codes over temperature |  | $\pm 1.0$ | LSB |
| Offset Error |  |  |  | $\pm 3.0$ | LSB |
| Gain Error (Note 3) |  |  |  | $\pm 3.0$ | LSB |
| Gain-Error Temperature Coefficient |  |  | $\pm 1.6$ |  | ppm $/{ }^{\circ} \mathrm{C}$ |
| Channel-to-Channel Offset-Error Matching |  |  | $\pm 0.2$ |  | LSB |
| DYNAMIC SPECIFICATIONS (100kHz sine-wave input, 2.5Vp-p, 400ksps, 6.4 MHz clock, bipolar input mode) |  |  |  |  |  |
| Signal-to-Noise plus Distortion Ratio | SINAD |  | 60 |  | dB |
| Total Harmonic Distortion | THD | Up to the 5th harmonic | -70 |  | dB |
| Spurious-Free Dynamic Range | SFDR |  | 70 |  | dB |
| Intermodulation Distortion | IMD | $\mathrm{fin}^{\prime}=99 \mathrm{kHz}$, fin2 $=102 \mathrm{kHz}$ | 76 |  | dB |
| Channel-to-Channel Crosstalk (Note 4) |  | $200 \mathrm{kHz}, \mathrm{V}$ IN $=2.5 \mathrm{Vp}-\mathrm{p}$ | -78 |  | dB |
| Full-Power Bandwidth |  | -3dB point | 6 |  | MHz |
| Full-Linear Bandwidth |  | SINAD > 58dB | 350 |  | kHz |
| CONVERSION RATE |  |  |  |  |  |
| Conversion Time (Note 5) | tconv |  | 2.5 |  | $\mu \mathrm{s}$ |
| Track/Hold Acquisition Time | tACQ |  |  | 400 | ns |
| Aperture Delay |  |  | 10 |  | ns |
| Aperture Jitter |  |  | <50 |  | ps |
| Serial Clock Frequency | fsclk |  | 0.5 | 6.4 | MHz |
| Duty Cycle |  |  | 40 | 60 | \% |

MAX1082/MAX1083

## 300ksps/400ksps, Single-Supply, 4-Channel, Serial 10-Bit ADCs with Internal Reference

## ELECTRICAL CHARACTERISTICS—MAX1082 (continued)

$\left(V_{\text {DD1 }}=\mathrm{V}_{\text {DD2 }}=+4.5 \mathrm{~V}\right.$ to $+5.5 \mathrm{~V}, \mathrm{COM}=\mathrm{GND}$, fosc $=6.4 \mathrm{MHz}, 50 \%$ duty cycle, 16 clocks/conversion cycle (400ksps), external $+2.5 \mathrm{~V}$ at REF, REFADJ $=\mathrm{V}_{\text {DD1 }}, \mathrm{T}_{A}=\mathrm{T}_{\text {MIN }}$ to $\mathrm{T}_{\mathrm{MAX}}$, unless otherwise noted. Typical values are at $\mathrm{T}_{\mathrm{A}}=+25^{\circ} \mathrm{C}$.)

| PARAMETER | SYMBOL | CONDITIONS | MIN | TYP MAX | UNITS |
| :---: | :---: | :---: | :---: | :---: | :---: |
| ANALOG INPUTS (CH3-CH0, COM) |  |  |  |  |  |
| Input Voltage Range, Single Ended and Differential (Note 6) | $\mathrm{V}_{\mathrm{CH}}$ | Unipolar, V COM $=0 \mathrm{~V}$ |  | VREF | V |
|  |  | Bipolar, $\mathrm{V}_{\mathrm{COM}}$ or $\mathrm{V}_{\mathrm{CH}}=\mathrm{V}_{\mathrm{REF}} / 2$, referenced to COM or $\mathrm{CH}_{-}$ |  | $\pm \mathrm{V}_{\text {REF/2 }}$ |  |
| Multiplexer Leakage Current |  | On/off leakage current, $\mathrm{V}_{\mathrm{COM}} \mathrm{V}_{\mathrm{CH}_{-}}=0$ or $\mathrm{V}_{\mathrm{DD} 1}$ |  | $\pm 0.001 \pm 1$ | $\mu \mathrm{A}$ |
| Input Capacitance |  |  |  | 18 | pF |
| INTERNAL REFERENCE |  |  |  |  |  |
| REF Output Voltage | VREF | $\mathrm{T}_{\mathrm{A}}=+25^{\circ} \mathrm{C}$ | 2.480 | $2.500 \quad 2.520$ | V |
| REF Short-Circuit Current |  |  |  | 15 | mA |
| REF Output Temperature Coefficient | TC V $\mathrm{R}_{\text {ef }}$ |  |  | $\pm 15$ | ppm $/{ }^{\circ} \mathrm{C}$ |
| Load Regulation (Note 7) |  | 0 to 1mA output load |  | $0.05 \quad 2.0$ | $\mathrm{mV} / \mathrm{mA}$ |
| Capacitive Bypass at REF |  |  | 4.7 | 10 | $\mu \mathrm{F}$ |
| Capacitive Bypass at REFADJ |  |  | 0.01 | 10 | $\mu \mathrm{F}$ |
| REFADJ Output Voltage |  |  |  | 1.22 | V |
| REFADJ Input Range |  | For small adjustments, from 1.22V |  | $\pm 100$ | mV |
| REFADJ Buffer Disable Threshold |  | To power down the internal reference | 1.4 | VDD1-1.0 | V |
| Buffer Voltage Gain |  |  |  | +2.05 | V/V |
| EXTERNAL REFERENCE (reference buffer disabled, reference applied to REF) |  |  |  |  |  |
| REF Input Voltage Range |  | (Note 8) | 1.0 | VDD1 + 50 mV | V |
| REF Input Current |  | $\mathrm{V}_{\text {REF }}=2.500 \mathrm{~V}$, fSCLK $=\mathrm{f}_{\text {MAX }}$ |  | 200350 | $\mu \mathrm{A}$ |
|  |  | $\mathrm{V}_{\text {REF }}=2.500 \mathrm{~V}$, fSCLK $=0$ |  | 320 |  |
|  |  | In full power-down mode, fSCLK $=0$ |  | 5 |  |
| DIGITAL INPUTS (DIN, SCLK, $\overline{C S} \overline{\text { S }} \overline{\text { SHDN }}$ ) |  |  |  |  |  |
| Input High Voltage | VINH |  | 3.0 |  | V |
| Input Low Voltage | $V_{\text {INL }}$ |  |  | 0.8 | V |
| Input Hysteresis | V HYST |  |  | 0.2 | V |
| Input Leakage | IIN | VIN $=0 \mathrm{~V}$ or $\mathrm{V}_{\text {DD2 }}$ |  | $\pm 1$ | $\mu \mathrm{A}$ |
| Input Capacitance | CIN |  |  | 15 | pF |
| DIGITAL OUTPUTS (DOUT, SSTRB) |  |  |  |  |  |
| Output Voltage Low | VOL | ISINK $=5 \mathrm{~mA}$ |  | 0.4 | V |
| Output Voltage High | V OH | ISOURCE $=1 \mathrm{~mA}$ | 4 |  | V |
| Three-State Leakage Current | IL | $\overline{\mathrm{CS}}=\mathrm{V}_{\mathrm{DD} 2}$ |  | $\pm 10$ | $\mu \mathrm{A}$ |
| Three-State Output Capacitance | Cout | $\overline{\mathrm{CS}}=\mathrm{V}_{\mathrm{DD} 2}$ |  | 15 | pF |

## MAX1082/MAX1083

## 300ksps/400ksps, Single-Supply, 4-Channel, Serial 10-Bit ADCs with Internal Reference

## ELECTRICAL CHARACTERISTICS—MAX1082 (continued)

$\left(V_{\text {DD1 }}=\mathrm{V}_{\mathrm{DD} 2}=+4.5 \mathrm{~V}\right.$ to $+5.5 \mathrm{~V}, \mathrm{COM}=\mathrm{GND}$, fosc $=6.4 \mathrm{MHz}, 50 \%$ duty cycle, 16 clocks/conversion cycle (400ksps), external $+2.5 \mathrm{~V}$ at REF, REFADJ $=V_{D D 1}, T_{A}=T_{\text {MIN }}$ to $T_{\text {MAX }}$, unless otherwise noted. Typical values are at $T_{A}=+25^{\circ} \mathrm{C}$.

| PARAMETER | SYMBOL | CONDITIONS |  | MIN | TYP | MAX | UNITS |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| POWER SUPPLY |  |  |  |  |  |  |  |
| Positive Supply Voltage (Note 9) | VDD1, <br> VDD2 |  |  | 4.5 |  | 5.5 | V |
| Supply Current | $\begin{aligned} & \text { IVDD1 } \\ + & \text { IVDD2 } \end{aligned}$ | $\begin{aligned} & V_{D D 1}= \\ & V_{D D 2}= \\ & 5.5 \mathrm{~V} \end{aligned}$ | Normal operating mode (Note 10) |  | 2.5 | 4.0 | mA |
|  |  |  | Reduced-power mode (Note 11) |  | 1.3 | 2.0 |  |
|  |  |  | Fast power-down mode (Note 11) |  | 0.9 | 1.5 |  |
|  |  |  | Full power-down mode (Note 11) |  | 2.0 | 10 | $\mu \mathrm{A}$ |
| Power-Supply Rejection | PSR | $\mathrm{V}_{\mathrm{DD1}}=\mathrm{V}_{\mathrm{DD2}}=5 \mathrm{~V} \pm 10 \%$, midscale input |  |  | $\pm 0.5$ | $\pm 2.0$ | mV |

## ELECTRICAL CHARACTERISTICS—MAX1083

$\left(V_{\text {DD1 }}=\mathrm{V}_{\mathrm{DD} 2}=+2.7 \mathrm{~V}\right.$ to $+3.6 \mathrm{~V}, \mathrm{COM}=\mathrm{GND}, \mathrm{fOSC}=4.8 \mathrm{MHz}, 50 \%$ duty cycle, 16 clocks/conversion cycle (300ksps), external +2.5 V at REF, REFADJ $=\mathrm{V}_{\text {DD1 }}, \mathrm{T}_{\mathrm{A}}=\mathrm{T}_{\text {MIN }}$ to $\mathrm{T}_{\text {MAX }}$, unless otherwise noted. Typical values are at $\mathrm{T}_{\mathrm{A}}=+25^{\circ} \mathrm{C}$.)

| PARAMETER | SYMBOL | CONDITIONS | MIN TYP | MAX | UNITS |
| :---: | :---: | :---: | :---: | :---: | :---: |
| DC ACCURACY (Note 1) |  |  |  |  |  |
| Resolution |  |  | 10 |  | bits |
| Relative Accuracy (Note 2) | INL | MAX1083A |  | $\pm 0.5$ | LSB |
|  |  | MAX1083B |  | $\pm 1.0$ |  |
| Differential Nonlinearity | DNL | No missing codes over temperature |  | $\pm 1.0$ | LSB |
| Offset Error |  |  |  | $\pm 3.0$ | LSB |
| Gain Error (Note 3) |  |  |  | $\pm 3.0$ | LSB |
| Gain-Error Temperature Coefficient |  |  | $\pm 1.6$ |  | ppm $/{ }^{\circ} \mathrm{C}$ |
| Channel-to-Channel Offset-Error Matching |  |  | $\pm 0.2$ |  | LSB |
| DYNAMIC SPECIFICATIONS (75kHz sine wave input, $2.5 \mathrm{Vp}-\mathrm{p}, 300 \mathrm{ksps}, 4.8 \mathrm{MHz}$ clock, bipolar input mode) |  |  |  |  |  |
| Signal-to-Noise plus Distortion Ratio | SINAD |  | 60 |  | dB |
| Total Harmonic Distortion | THD | Up to the 5th harmonic | -70 |  | dB |
| Spurious-Free Dynamic Range | SFDR |  | 70 |  | dB |
| Intermodulation Distortion | IMD | $\mathrm{fiN1}=73 \mathrm{kHz}$, fin $2=77 \mathrm{kHz}$ | 76 |  | dB |
| Channel-to-Channel Crosstalk (Note 4) |  | $\mathrm{f}=150 \mathrm{kHz}, \mathrm{V}_{\text {IN }}=2.5 \mathrm{Vp}-\mathrm{p}$ | -78 |  | dB |
| Full-Power Bandwidth |  | -3dB point | 3 |  | MHz |
| Full-Linear Bandwidth |  | SINAD > 58dB | 250 |  | kHz |

MAX1082/MAX1083

## 300ksps/400ksps, Single-Supply, 4-Channel, Serial 10-Bit ADCs with Internal Reference

## ELECTRICAL CHARACTERISTICS-MAX1083 (continued)

$\left(V_{\text {DD1 }}=\mathrm{V}_{\mathrm{DD} 2}=+2.7 \mathrm{~V}\right.$ to $+3.6 \mathrm{~V}, \mathrm{COM}=\mathrm{GND}, \mathrm{fOSC}=4.8 \mathrm{MHz}, 50 \%$ duty cycle, 16 clocks/conversion cycle (300ksps), external +2.5 V at REF, REFADJ $=\mathrm{V}_{\mathrm{DD} 1}, \mathrm{~T}_{\mathrm{A}}=\mathrm{T}_{\mathrm{MIN}}$ to $\mathrm{T}_{\mathrm{MAX}}$, unless otherwise noted. Typical values are at $\mathrm{T}_{\mathrm{A}}=+25^{\circ} \mathrm{C}$.)

| PARAMETER | SYMBOL | CONDITIONS | MIN | TYP | MAX | UNITS |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| CONVERSION RATE |  |  |  |  |  |  |
| Conversion Time (Note 5) | tCONV | Normal operating mode | 3.3 |  |  | $\mu \mathrm{s}$ |
| Track/Hold Acquisition Time | tacQ | Normal operating mode |  |  | 625 | ns |
| Aperture Delay |  |  |  | 10 |  | ns |
| Aperture Jitter |  |  |  | <50 |  | ps |
| Serial Clock Frequency | fsclk | Normal operating mode | 0.5 |  | 4.8 | MHz |
| Duty Cycle |  |  | 40 |  | 60 | \% |
| ANALOG INPUTS (CH3-CH0, COM) |  |  |  |  |  |  |
| Input Voltage Range, Single Ended and Differential (Note 6) | $\mathrm{V}_{\mathrm{CH}}$ | Unipolar, V COM $=0 \mathrm{~V}$ | $\mathrm{V}_{\text {REF }}$$\pm \mathrm{V}_{\text {REF } / 2}$ |  |  | V |
|  |  | Bipolar, $\mathrm{V}_{\mathrm{COM}}$ or $\mathrm{V}_{\mathrm{CH}}=\mathrm{V}_{\text {REF }} / 2$, referenced to COM or $\mathrm{CH}_{-}$ |  |  |  |  |
| Multiplexer Leakage Current |  | On/off leakage current, $\mathrm{V}_{\text {CH_ }}=0 \mathrm{~V}$ or $\mathrm{V}_{\text {DD1 }}$ |  | $\pm 0.001$ | $\pm 1$ | $\mu \mathrm{A}$ |
| Input Capacitance |  |  |  | 18 |  | pF |
| INTERNAL REFERENCE |  |  |  |  |  |  |
| REF Output Voltage | VREF | $\mathrm{T}_{\mathrm{A}}=+25^{\circ} \mathrm{C}$ | 2.480 | 2.500 | 2.520 | V |
| REF Short-Circuit Current |  |  |  | 15 |  | mA |
| REF Output Temperature Coefficient | TC V ReF |  |  | $\pm 15$ |  | ppm $/{ }^{\circ} \mathrm{C}$ |
| Load Regulation (Note 7) |  | 0 to 0.75 mA output load |  | 0.1 | 2.0 | $\mathrm{mV} / \mathrm{mA}$ |
| Capacitive Bypass at REF |  |  | 4.7 |  | 10 | $\mu \mathrm{F}$ |
| Capacitive Bypass at REFADJ |  |  | 0.01 |  | 10 | $\mu \mathrm{F}$ |
| REFADJ Output Voltage |  |  |  | 1.22 |  | V |
| REFADJ Input Range |  | For small adjustments, from 1.22V |  | $\pm 100$ |  | mV |
| REFADJ Buffer Disable Threshold |  | To power down the internal reference | 1.4 |  | VDD1-1 | V |
| Buffer Voltage Gain |  |  |  | +2.05 |  | V/V |
| EXTERNAL REFERENCE (reference buffer disabled, reference applied to REF) |  |  |  |  |  |  |
| REF Input Voltage Range |  | (Note 8) | 1.0 |  | $\begin{aligned} & \text { VDD1 + } \\ & 50 \mathrm{mV} \end{aligned}$ | V |
| REF Input Current |  | $\mathrm{V}_{\text {REF }}=2.500 \mathrm{~V}, \mathrm{fSCLK}=\mathrm{f}_{\text {MAX }}$ |  | 200 | 350 | $\mu \mathrm{A}$ |
|  |  | $\mathrm{V}_{\text {REF }}=2.500 \mathrm{~V}$, fSCLK $=0$ |  |  | 320 |  |
|  |  | In full power-down mode, fSCLK $=0$ |  |  | 5 |  |
| DIGITAL INPUTS (DIN, SCLK, $\overline{\mathrm{CS}}, \overline{\text { SHDN }}$ ) |  |  |  |  |  |  |
| Input High Voltage | VINH |  | 2.0 |  |  | V |
| Input Low Voltage | VINL |  |  |  | 0.8 | V |
| Input Hysteresis | VHYST |  |  | 0.2 |  | V |
| Input Leakage | IIN | V IN $=0 \mathrm{~V}$ or $\mathrm{V}_{\text {DD2 }}$ |  |  | $\pm 1$ | $\mu \mathrm{A}$ |
| Input Capacitance | CIN |  |  | 15 |  | pF |

## MAX1082/MAX1083

## 300ksps/400ksps, Single-Supply, 4-Channel, Serial 10-Bit ADCs with Internal Reference

## ELECTRICAL CHARACTERISTICS—MAX1083 (continued)

$\left(V_{D D 1}=V_{D D 2}=+2.7 \mathrm{~V}\right.$ to $+3.6 \mathrm{~V}, \mathrm{COM}=\mathrm{GND}, \mathrm{fOSc}=4.8 \mathrm{MHz}, 50 \%$ duty cycle, 16 clocks/conversion cycle (300ksps), external +2.5 V at REF, REFADJ $=\mathrm{V}_{\mathrm{DD} 1}, \mathrm{~T}_{\mathrm{A}}=\mathrm{T}_{\text {MIN }}$ to $\mathrm{T}_{\text {MAX }}$, unless otherwise noted. Typical values are at $\mathrm{T}_{\mathrm{A}}=+25^{\circ} \mathrm{C}$.)

| PARAMETER | SYMBOL |  | CONDITIONS | MIN TYP | MAX | UNITS |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| DIGITAL OUTPUTS (DOUT, SSTRB) |  |  |  |  |  |  |
| Output Voltage Low | VoL | ISINK $=5 \mathrm{~mA}$ |  |  | 0.4 | V |
| Output Voltage High | VOH | ISOURCE $=0.5 \mathrm{~mA}$ |  | VDD2-0.5V |  | V |
| Three-State Leakage Current | IL | $\overline{\mathrm{CS}}=\mathrm{V}_{\mathrm{DD} 2}$ |  |  | $\pm 10$ | $\mu \mathrm{A}$ |
| Three-State Output Capacitance | Cout | $\overline{\mathrm{CS}}=\mathrm{V}_{\mathrm{DD} 2}$ |  | 15 |  | pF |
| POWER SUPPLY |  |  |  |  |  |  |
| Positive Supply Voltage (Note 9) | VDD1, <br> VDD2 |  |  | 2.7 | 3.6 | V |
| Supply Current | IVDD1 <br> $+\mathrm{IV}_{\mathrm{DD}}$ | $V_{D D 1}=$ <br> VDD2 $=$ <br> 3.6 V | Normal operating mode (Note 10) | 2.5 | 3.5 | mA |
|  |  |  | Reduced-power mode (Note 11) | 1.3 | 2.0 |  |
|  |  |  | Fast power-down mode (Note 11) | 0.9 | 1.5 |  |
|  |  |  | Full power-down mode (Note 11) | 2.0 | 1.0 | $\mu \mathrm{A}$ |
| Power-Supply Rejection | PSR | $\mathrm{V}_{\mathrm{DD} 1}=\mathrm{V}_{\mathrm{DD2}}=2.7 \mathrm{~V}$ to 3.6V, midscale input |  | $\pm 0.5$ | $\pm 2.0$ | mV |

## TIMING CHARACTERISTICS—MAX1082

(Figures 1, 2, 5, 6; $\mathrm{V}_{\mathrm{DD} 1}=\mathrm{V}_{\mathrm{DD} 2}=+4.5 \mathrm{~V}$ to $+5.5 \mathrm{~V} ; \mathrm{T}_{\mathrm{A}}=\mathrm{T}_{\mathrm{MIN}}$ to $\mathrm{T}_{\mathrm{MAX}}$; unless otherwise noted.)

| PARAMETER | SYMBOL | CONDITIONS | MIN | TYP | MAX | UNITS |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| SCLK Period | tcP |  | 156 |  |  | ns |
| SCLK Pulse Width High | tch |  | 62 |  |  | ns |
| SCLK Pulse Width Low | tCL |  | 62 |  |  | ns |
| DIN to SCLK Setup | tDS |  | 35 |  |  | ns |
| DIN to SCLK Hold | tD |  | 0 |  |  | ns |
| $\overline{\text { CS }}$ Fall to SCLK Rise Setup | tcss |  | 35 |  |  | ns |
| SCLK Rise to $\overline{\mathrm{CS}}$ Rise Hold | tcSH |  | 0 |  |  | ns |
| SCLK Rise to $\overline{\mathrm{CS}}$ Fall Ignore | tcso |  | 35 |  |  | ns |
| $\overline{\mathrm{CS}}$ Rise to SCLK Rise Ignore | tcs1 |  | 35 |  |  | ns |
| SCLK Rise to DOUT Hold | tDOH | CLOAD $=20 \mathrm{pF}$ | 10 | 20 |  | ns |
| SCLK Rise to SSTRB Hold | tSTH | CLOAD $=20 \mathrm{pF}$ | 10 | 20 |  | ns |
| SCLK Rise to DOUT Valid | tDOV | CLOAD $=20 \mathrm{pF}$ |  |  | 80 | ns |
| SCLK Rise to SSTRB Valid | tSTV | CLOAD $=20 \mathrm{pF}$ |  |  | 80 | ns |
| $\overline{\mathrm{CS}}$ Rise to DOUT Disable | tDOD | CLOAD $=20 \mathrm{pF}$ | 10 |  | 65 | ns |
| $\overline{\mathrm{CS}}$ Rise to SSTRB Disable | tSTD | CLOAD $=20 \mathrm{pF}$ | 10 |  | 65 | ns |
| $\overline{\overline{C S}}$ Fall to DOUT Enable | tDoe | CLOAD $=20 \mathrm{pF}$ |  |  | 65 | ns |
| $\overline{\mathrm{CS}}$ Fall to SSTRB Enable | tste | CLOAD $=20 \mathrm{pF}$ |  |  | 65 | ns |
| $\overline{\overline{C S}}$ Pulse Width High | tcsw |  | 100 |  |  | ns |

MAX1082/MAX1083

## 300ksps/400ksps, Single-Supply, 4-Channel, Serial 10-Bit ADCs with Internal Reference

## TIMING CHARACTERISTICS—MAX1083

(Figures 1, 2, 5, 6; $\mathrm{V}_{\mathrm{DD} 1}=\mathrm{V}_{\mathrm{DD} 2}=+2.7 \mathrm{~V}$ to $+3.6 \mathrm{~V} ; \mathrm{T}_{\mathrm{A}}=\mathrm{T}_{\mathrm{MIN}}$ to $\mathrm{T}_{\mathrm{MAX}}$; unless otherwise noted.)

| PARAMETER | SYMBOL | CONDITIONS | MIN | TYP | MAX | UNITS |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| SCLK Period | $\mathrm{t}_{\mathrm{CP}}$ |  | 208 |  |  | ns |
| SCLK Pulse Width High | tch |  | 83 |  |  | ns |
| SCLK Pulse Width Low | $\mathrm{t}_{\mathrm{CL}}$ |  | 83 |  |  | ns |
| DIN to SCLK Setup | tDS |  | 45 |  |  | ns |
| DIN to SCLK Hold | tDH |  | 0 |  |  | ns |
| $\overline{\overline{C S}}$ Fall to SCLK Rise Setup | tcss |  | 45 |  |  | ns |
| SCLK Rise to $\overline{\mathrm{CS}}$ Rise Hold | tcse |  | 0 |  |  | ns |
| SCLK Rise to $\overline{\mathrm{CS}}$ Fall ignore | tcso |  | 45 |  |  | ns |
| $\overline{\overline{C S}}$ Rise to SCLK Rise Ignore | tCS1 |  | 45 |  |  | ns |
| SCLK Rise to DOUT Hold | tDOH | CLOAD $=20 \mathrm{pF}$ | 13 | 20 |  | ns |
| SCLK Rise to SSTRB Hold | tSTH | CLOAD $=20 \mathrm{pF}$ | 13 | 20 |  | ns |
| SCLK Rise to DOUT Valid | toov | CLOAD $=20 \mathrm{pF}$ |  |  | 100 | ns |
| SCLK Rise to SSTRB Valid | tsTV | CLOAD $=20 \mathrm{pF}$ |  |  | 100 | ns |
| $\overline{\overline{C S}}$ Rise to DOUT Disable | tDOD | CLOAD $=20 \mathrm{pF}$ | 13 |  | 85 | ns |
| $\overline{\text { CS }}$ Rise to SSTRB Disable | tSTD | CLOAD $=20 \mathrm{pF}$ | 13 |  | 85 | ns |
| $\overline{\mathrm{CS}}$ Fall to DOUT Enable | tdoe | CLOAD $=20 \mathrm{pF}$ |  |  | 85 | ns |
| $\overline{\overline{C S}}$ Fall to SSTRB Enable | tste | CLOAD $=20 \mathrm{pF}$ |  |  | 85 | ns |
| $\overline{\overline{C S}}$ Pulse Width High | tcsw |  | 100 |  |  | ns |

Note 1: $\quad$ Tested at $V_{D D 1}=V_{D D 2}=V_{D D(M I N)} ; C O M=G N D$, unipolar single-ended input mode.
Note 2: Relative accuracy is the deviation of the analog value at any code from its theoretical value after the full-scale range has been calibrated.
Note 3: Offset nulled.
Note 4: Ground the "on" channel; sine wave is applied to all "off" channels.
Note 5: Conversion time is defined as the number of clock cycles multiplied by the clock period; clock has 50\% duty cycle.
Note 6: The common-mode range for the analog inputs ( $\mathrm{CH} 3-\mathrm{CH} 0$ and COM ) is from GND to $\mathrm{V}_{\mathrm{DD}}$.
Note 7: External load should not change during conversion for specified accuracy.
Note 8: ADC performance is limited by the converter's noise floor, typically $300 \mu \mathrm{Vp}$-p. An external reference below 2.5 V compromises the performance of the ADC.
Note 9: Electrical characteristics are guaranteed from $V_{D D 1(M I N)}=V_{D D 2(M I N)}$ to $V_{D D 1(M A X)}=V_{D D 2(M A X)}$. For operations beyond this range, see Typical Operating Characteristics. For guaranteed specifications beyond the limits, contact the factory.
Note 10: $\mathrm{AIN}=$ midscale. Unipolar Mode. MAX1082 tested with 20 pF on DOUT, 20 pF on SSTRB, and fscLK $=6.4 \mathrm{MHz}, 0$ to 5 V . MAX1083 tested with same loads, fSCLK $=4.8 \mathrm{MHz}, 0$ to 3 V .
Note 11: SCLK = DIN = GND. $\overline{C S}=V_{D D 1}$.

## MAX1082/MAX1083

## 300ksps/400ksps, Single-Supply, 4-Channel, Serial 10-Bit ADCs with Internal Reference

Typical Operating Characteristics
(MAX1082: $V_{D D 1}=V_{D D 2}=5.0 \mathrm{~V}$, fSCLK $=6.4 \mathrm{MHz} ;$ MAX1083: $\mathrm{V}_{\mathrm{DD} 1}=\mathrm{V}_{\mathrm{DD} 2}=3.0 \mathrm{~V}$, fSCLK $=4.8 \mathrm{MHz} ;$ CLOAD $=20 \mathrm{pF}, 4.7 \mu \mathrm{~F}$ capacitor at REF, $0.01 \mu \mathrm{~F}$ capacitor at REFADJ, $\mathrm{T}_{\mathrm{A}}=+25^{\circ} \mathrm{C}$, unless otherwise noted.)



SHUTDOWN SUPPLY CURRENT vs. SUPPLY VOLTAGE


DIFFERENTIAL NONLINEARITY vs. DIGITAL OUTPUT CODE


SUPPLY CURRENT vs. SUPPLY
VOLTAGE (STATIC)


SHUTDOWN SUPPLY CURRENT
vs. TEMPERATURE



SUPPLY CURRENT vs. TEMPERATURE (STATIC)


REFERENCE VOLTAGE vs. SUPPLY VOLTAGE


## 300ksps/400ksps, Single-Supply, 4-Channel,

 Serial 10-Bit ADCs with Internal ReferenceTypical Operating Characteristics (continued)
$\left(M A X 1082: V_{D D 1}=V_{D D 2}=5.0 \mathrm{~V}, \mathrm{f}_{\mathrm{DLLK}}=6.4 \mathrm{MHz} ; \mathrm{MAX1083}: \mathrm{V}_{\mathrm{DD} 1}=\mathrm{V}_{\mathrm{DD}}=3.0 \mathrm{~V}, \mathrm{f}_{\mathrm{SLLK}}=4.8 \mathrm{MHz} ; \mathrm{CLOAD}=20 \mathrm{pF}, 4.7 \mu \mathrm{~F}\right.$ capacitor at REF, $0.01 \mu F$ capacitor at REFADJ, $\mathrm{T}_{\mathrm{A}}=+25^{\circ} \mathrm{C}$, unless otherwise noted.)




## MAX1082/MAX1083

## 300ksps/400ksps, Single-Supply, 4-Channel, Serial 10-Bit ADCs with Internal Reference

Pin Description

| PIN | NAME | FUNCTION |
| :---: | :---: | :---: |
| 1 | VDD1 | Positive Supply Voltage |
| 2-5 | CHO-CH3 | Sampling Analog Inputs |
| 6 | COM | Ground Reference for Analog Inputs. COM sets zero-code voltage in single-ended mode. Must be stable to $\pm 0.5 \mathrm{LSB}$. |
| 7 | $\overline{\text { SHDN }}$ | Active-Low Shutdown Input. Pulling $\overline{\text { SHDN }}$ low shuts down the device, reducing supply current to $2 \mu \mathrm{~A}$ (typ). |
| 8 | REF | Reference-Buffer Output/ADC Reference Input. Reference voltage for analog-to-digital conversion. In internal reference mode, the reference buffer provides a 2.500 V nominal output, externally adjustable at REFADJ. In external reference mode, disable the internal buffer by pulling REFADJ to VDD1. |
| 9 | REFADJ | Input to the Reference-Buffer Amplifier. To disable the reference-buffer amplifier, connect REFADJ to VDD1. |
| 10 | GND | Ground |
| 11 | DOUT | Serial-Data Output. Data is clocked out at SCLK's rising edge. High impedance when $\overline{\mathrm{CS}}$ is high. |
| 12 | SSTRB | Serial Strobe Output. SSTRB pulses high for one clock period before the MSB decision. High impedance when $\overline{\mathrm{CS}}$ is high. |
| 13 | DIN | Serial-Data Input. Data is clocked in at SCLK's rising edge. |
| 14 | $\overline{\mathrm{CS}}$ | Active-Low Chip Select. Data will not be clocked into DIN unless $\overline{\mathrm{CS}}$ is low. When $\overline{\mathrm{CS}}$ is high, DOUT and SSTRB are high impedance. |
| 15 | SCLK | Serial-Clock Input. Clocks data in and out of serial interface and sets the conversion speed. (Duty cycle must be $40 \%$ to 60\%.) |
| 16 | VDD2 | Positive Supply Voltage |



Figure 1. Load Circuits for Enable Time


Figure 2. Load Circuits for Disable Time

## 300ksps/400ksps, Single-Supply, 4-Channel, Serial 10-Bit ADCs with Internal Reference

## Detailed Description

The MAX1082/MAX1083 ADCs use a successiveapproximation conversion technique and input T/H circuitry to convert an analog signal to a 10-bit digital output. A flexible serial interface provides easy interface to microprocessors ( $\mu \mathrm{Ps}$ ). Figure 3 shows a functional diagram of the MAX1082/MAX1083.

## Pseudo-Differential Input

The equivalent circuit of Figure 4 shows the MAX1082/ MAX1083's input architecture, which is composed of a T/H, input multiplexer, input comparator, switchedcapacitor DAC, and reference.
In single-ended mode, the positive input ( $\mathrm{IN}+$ ) is connected to the selected input channel and the negative input (IN-) is set to COM. In differential mode, IN+ and IN - are selected from the following pairs: $\mathrm{CHO} / \mathrm{CH} 1$ and $\mathrm{CH} 2 / \mathrm{CH} 3$. Configure the channels according to Tables 1 and 2.
The MAX1082/MAX1083 input configuration is pseudodifferential because only the signal at IN+ is sampled. The return side ( IN -) is connected to the sampling capacitor while converting and must remain stable within $\pm 0.5 \mathrm{LSB}( \pm 0.1 \mathrm{LSB}$ for best results) with respect to GND during a conversion.
If a varying signal is applied to the selected IN -, its amplitude and frequency must be limited to maintain accuracy. The following equations express the relationship between the maximum signal amplitude and its frequency to maintain $\pm 0.5$ LSB accuracy. Assuming a


Figure 3. Functional Diagram
sinusoidal signal at IN -, the input voltage is determined by:

$$
\mathrm{V}_{\mathbb{N}}-=\left(\mathrm{V}_{\mathbb{N}}-\right) \sin (2 \pi \mathrm{ft})
$$

The maximum voltage variation is determined by:

$$
\max \frac{d_{\left(V_{I N}-\right)}}{d t}=V_{I N}-2 \pi f \leq \frac{1 \mathrm{LSB}}{t_{\mathrm{CONV}}}=\frac{V_{\mathrm{REF}}}{2^{10_{\mathrm{C}}} \mathrm{t}_{\mathrm{CONV}}}
$$

A $2.6 \mathrm{Vp}-\mathrm{p}, 60 \mathrm{~Hz}$ signal at IN - will generate $\mathrm{a} \pm 0.5 \mathrm{LSB}$ error when using a +2.5 V reference voltage and a $2.5 \mu \mathrm{~s}$ conversion time ( $15 / \mathrm{fSCLK}$ ). When a DC reference voltage is used at IN-, connect a $0.1 \mu \mathrm{~F}$ capacitor to GND to minimize noise at the input.
During the acquisition interval, the channel selected as the positive input ( $\mathrm{IN}+$ ) charges capacitor ChOLD. The acquisition interval spans three SCLK cycles and ends on the falling SCLK edge after the input control word's last bit has been entered. At the end of the acquisition interval, the $\mathrm{T} / \mathrm{H}$ switch opens, retaining charge on Chold as a sample of the signal at $\mathrm{IN}+$. The conversion interval begins with the input multiplexer switching Chold from IN+ to IN-. This unbalances node ZERO at the comparator's input. The capacitive DAC adjusts during the remainder of the conversion cycle to restore node ZERO to VDD1/2 within the limits of 10-bit resolution. This action is equivalent to transferring a $12 \mathrm{pF} \times\left(\mathrm{V}_{\mathrm{IN}}+-\mathrm{VIN}^{-}\right)$charge from CHOLD to the binaryweighted capacitive DAC, which in turn forms a digital representation of the analog input signal.


Figure 4. Equivalent Input Circuit

## MAX1082/MAX1083

## 300ksps/400ksps, Single-Supply, 4-Channel, Serial 10-Bit ADCs with Internal Reference

## Track/Hold

The T/H enters its tracking mode on the falling clock edge after the fifth bit of the 8-bit control word has been shifted in. It enters its hold mode on the falling clock edge after the eighth bit of the control word has been shifted in. If the converter is set up for single-ended inputs, IN - is connected to COM and the converter samples the "+" input. If the converter is set up for differential inputs, the difference of $[(\mathrm{IN}+)-(\mathrm{IN}-)]$ is converted. At the end of the conversion, the positive input connects back to IN+ and ChOLD charges to the input signal.
The time required for the $\mathrm{T} / \mathrm{H}$ to acquire an input signal is a function of how quickly its input capacitance is charged. If the input signal's source impedance is high, the acquisition time lengthens, and more time must be allowed between conversions. The acquisition time, $t_{A C Q}$, is the maximum time the device takes to acquire the signal and the minimum time needed for the signal to be acquired. It is calculated by the following equation:

$$
t_{A C Q}=7 \times(R S+R I N) \times 18 p F
$$

where RIN $=800 \Omega$, RS $=$ the source impedance of the input signal, and tACQ is never less than 400ns (MAX1082) or 625ns (MAX1083). Note that source impedances below $4 k \Omega$ do not significantly affect the ADC's AC performance.

## Input Bandwidth

The ADC's input tracking circuitry has a 6 MHz (MAX1082) or 3MHz (MAX1083) small-signal bandwidth, so it is possible to digitize high-speed transient events and measure periodic signals with bandwidths exceeding the ADC's sampling rate by using undersampling techniques. To avoid high-frequency signals being aliased into the frequency band of interest, antialias filtering is recommended.

## Analog Input Protection

Internal protection diodes, which clamp the analog input to VDD1 and GND, allow the channel input pins to swing from GND - 0.3V to VDD1 +0.3 V without damage. However, for accurate conversions near full scale, the inputs must not exceed VDD1 by more than 50 mV or be lower than GND by 50 mV .
If the analog input exceeds 50 mV beyond the supplies, do not allow the input current to exceed $2 m A$.

How to Start a Conversion
Start a conversion by clocking a control byte into DIN. With $\overline{\mathrm{CS}}$ low, each rising edge on SCLK clocks a bit from

DIN into the MAX1082/MAX1083's internal shift register. After $\overline{\mathrm{CS}}$ falls, the first arriving logic "1" bit defines the control byte's MSB. Until this first "start" bit arrives, any number of logic "0" bits can be clocked into DIN with no effect. Table 3 shows the control-byte format.
The MAX1082/MAX1083 are compatible with SPI/ QSPI and MICROWIRE devices. For SPI, select the correct clock polarity and sampling edge in the SPI control registers: set CPOL $=0$ and $\mathrm{CPHA}=0$. MICROWIRE, SPI, and QSPI all transmit a byte and receive a byte at the same time. Using the Typical Operating Circuit, the simplest software interface requires only three 8-bit transfers to perform a conversion (one 8-bit transfer to configure the ADC, and two more 8-bit transfers to clock out the conversion result). See Figure 16 for MAX1082/ MAX1083 QSPI connections.

## Simple Software Interface

Make sure the CPU's serial interface runs in master mode so the CPU generates the serial clock. Choose a clock frequency from 500 kHz to 6.4 MHz (MAX1082) or 4.8 MHz (MAX1083).

1) Set up the control byte and call it TB1. TB1 should be of the format: $1 \times X X X X X X$ binary, where the Xs denote the particular channel, selected conversion mode, and power mode.
2) Use a general-purpose I/O line on the CPU to pull $\overline{\mathrm{CS}}$ low.
3) Transmit TB1 and, simultaneously, receive a byte and call it RB1. Ignore RB1.
4) Transmit a byte of all zeros (\$00 hex) and, simultaneously, receive byte RB2.
5) Transmit a byte of all zeros (\$00 hex) and, simultaneously, receive byte RB3.
6) Pull $\overline{C S}$ high.

Figure 5 shows the timing for this sequence. Bytes RB2 and RB3 contain the result of the conversion, padded with three leading zeros, two sub-LSB bits, and one trailing zero. The total conversion time is a function of the serial-clock frequency and the amount of idle time between 8-bit transfers. To avoid excessive T/H droop, make sure the total conversion time does not exceed $120 \mu \mathrm{~s}$.

## Digital Output

 In unipolar input mode, the output is straight binary (Figure 13). For bipolar input mode, the output is two's complement (Figure 14). Data is clocked out on the rising edge of SCLK in MSB-first format.
## 300ksps/400ksps, Single-Supply, 4-Channel, Serial 10-Bit ADCs with Internal Reference

Table 1. Channel Selection in Single-Ended Mode (SGL/DIF = 1)

| SEL2 | SEL1 | SELO | CHO | CH1 | CH2 | CH3 | COM |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| 0 | 0 | 1 | + |  |  | - |  |
| 1 | 0 | 1 |  | + |  | - |  |
| 0 | 1 | 0 |  |  | + | - |  |
| 1 | 1 | 0 |  |  |  | - |  |

Table 2. Channel Selection in Pseudo-Differential Mode (SGL/DIF $=0$ )

| SEL2 | SEL1 | SEL0 | CH0 | CH1 | CH2 | CH3 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| 0 | 0 | 1 | + | - |  |  |
| 0 | 1 | 0 |  |  | + | - |
| 1 | 0 | 1 | - | + |  |  |
| 1 | 1 | 0 |  |  | + |  |

## Serial Clock

The external clock not only shifts data in and out, but it also drives the analog-to-digital conversion steps. SSTRB pulses high for one clock period after the last bit of the control byte. Successive-approximation bit decisions are made and appear at DOUT on each of the next 12 SCLK falling edges, MSB first (Figure 5). SSTRB and DOUT go into a high-impedance state when $\overline{\mathrm{CS}}$ goes high; after the next $\overline{C S}$ falling edge, SSTRB outputs a logic low. Figure 6 shows the detailed serial-interface timings.
The conversion must complete in $120 \mu$ s or less, or droop on the sample-and-hold capacitors may degrade conversion results.

Data Framing
The falling edge of $\overline{\mathrm{CS}}$ does not start a conversion. The first logic high clocked into DIN is interpreted as a start bit and defines the first bit of the control byte. A conversion starts on SCLK's falling edge, after the eighth bit of the control byte (the PDO bit) is clocked into DIN. The start bit is defined as follows:

The first high bit clocked into DIN with $\overline{\mathrm{CS}}$ low any time the converter is idle; e.g., after VDD1 and VDD2 are applied.

## OR

The first high bit clocked into DIN after bit B4 of a conversion in progress is clocked onto the DOUT pin (Figure 7).
Once a start bit has been recognized, the current conversion may only be terminated by pulling SHDN low.

The fastest the MAX1082/MAX1083 can run with $\overline{\mathrm{CS}}$ held low between conversions is 16 clocks per conversion. Figure 7 shows the serial-interface timing necessary to perform a conversion every 16 SCLK cycles. If $\overline{C S}$ is tied low and SCLK is continuous, guarantee a start bit by first clocking in 16 zeros.

## Applications Information

Power-On Reset
When power is first applied, and if SHDN is not pulled low, internal power-on reset circuitry activates the MAX1082/MAX1083 in normal operating mode, ready to convert with SSTRB = low. After the power supplies stabilize, the internal reset time is $10 \mu \mathrm{~s}$, and no conversions should be performed during this phase. If $\overline{\mathrm{CS}}$ is low, the first logic 1 on DIN is interpreted as a start bit. Until a conversion takes place, DOUT shifts out zeros. Additionally, wait for the reference to stabilize when using the internal reference.

Power Modes
Save power by placing the converter in one of two lowcurrent operating modes or in full power-down between conversions. Select the power mode through bit 1 and bit 0 of the DIN control byte (Tables 3 and 4), or force the converter into hardware shutdown by driving $\overline{\mathrm{SHDN}}$ to GND.
The software power-down modes take effect after the conversion is completed; $\overline{\text { SHDN }}$ overrides any software power mode and immediately stops any conversion in progress. In software power-down mode, the serial interface remains active while waiting for a new control byte to start conversion and switch to full-power mode.

## MAX1082/MAX1083

## 300ksps/400ksps, Single-Supply, 4-Channel, Serial 10-Bit ADCs with Internal Reference

Table 3. Control-Byte Format

| BIT 7 <br> (MSB) | BIT 6 | BIT 5 | BIT 4 | BIT 3 | BIT 2 | BIT 1 | BIT 0 <br> (LSB) |
| :--- | :--- | :--- | :--- | :--- | :--- | :--- | :--- |
| START | SEL2 | SEL1 | SEL0 | UNI/BIP | SGL/DIF | PD1 | PD0 |


| BIT | NAME | DESCRIPTION |
| :---: | :---: | :---: |
| 7(MSB) | START | The first logic "1" bit after $\overline{\mathrm{CS}}$ goes low defines the beginning of the control byte. |
| 6 5 4 | $\begin{aligned} & \text { SEL2 } \\ & \text { SEL1 } \\ & \text { SELO } \end{aligned}$ | These 3 bits select which of the eight channels are used for the conversion (Tables 1 and 2). |
| 3 | UNI/ $\overline{\mathrm{BIP}}$ | $1=$ unipolar, $0=$ bipolar. Selects unipolar or bipolar conversion mode. In unipolar mode, an analog input signal from 0 to $V_{\text {REF }}$ can be converted; in bipolar mode, the differential signal can range from $-V_{\text {REF }} / 2$ to $+V_{\text {Ref }} / 2$. |
| 2 | SGL/DIF | 1 = single ended, $0=$ pseudo-differential. Selects single-ended or pseudo-differential conversions. In single-ended mode, input signal voltages are referred to COM. In pseudo-differential mode, the voltage difference between two channels is measured (Tables 1 and 2). |
| 1 | PD1 | Select operating mode. |
| O(LSB) | PDO | PD1 PD0 Mode <br> 0 0 Full power-down <br> 0 1 Fast power-down <br> 1 0 Reduced power <br> 1 1 Normal operation |

Table 4. Software-Controlled Power Modes

| PD1/PDO | MODE |  | TOTAL SUPPLY CURRENT |  | CIRCUIT SECTIONS* |  |
| :---: | :--- | :---: | :---: | :---: | :---: | :---: |
|  |  | CONVERTING <br> (mA) | AFTER <br> CONVERSION | INPUT COMPARATOR | REFERENCE |  |
| 00 | Full Power-Down <br> (FULLPD) | 2.5 | $2 \mu \mathrm{~A}$ | Off | Off |  |
| 01 | Fast Power-Down <br> (FASTPD) | 2.5 | 0.9 mA | Reduced Power | On |  |
| 10 | Reduced Power <br> Mode (REDP) | 2.5 | 1.3 mA | Reduced Power | On |  |
| 11 | Normal Operating | 2.5 | 2.0 mA | Full Power | On |  |

* Circuit operation between conversions; during conversion all circuits are fully powered up.

Once conversion is completed, the device goes into the programmed power mode until a new control byte is written.
The power-up delay is dependent on the power-down state. Software low-power modes will be able to start conversion immediately when running at decreased clock rates (see Power-Down Sequencing). Upon power-on reset, when exiting software full power-down
mode, or when exiting hardware shutdown, the device goes immediately into full-power mode and is ready to convert after $2 \mu$ s when using an external reference. When using the internal reference, wait for the typical power-up delay from a full power-down (software or hardware) as shown in Figure 8.

## 300ksps/400ksps, Single-Supply, 4-Channel, Serial 10-Bit ADCs with Internal Reference



Figure 5. Single-Conversion Timing

## Software Power-Down

Software power-down is activated using bits PD1 and PDO of the control byte. When software power-down is asserted, the ADC completes the conversion in progress and powers down into the specified low-qui-escent-current state $(2 \mu \mathrm{~A}, 0.9 \mathrm{~mA}$, or 1.3 mA$)$.
The first logic 1 on DIN is interpreted as a start bit and puts the MAX1082/MAX1083 into its full-power mode. Following the start bit, the data input word or control byte also determines the next power-down state. For example, if the DIN word contains PD1 = 0 and $\mathrm{PDO}=1$, a 0.9 mA power-down resumes after one conversion. Table 4 details the four power modes with the corresponding supply current and operating sections.

## Hardware Power-Down

Pulling $\overline{\text { SHDN }}$ low places the converter in hardware power-down. Unlike software power-down mode, the conversion is not completed; it stops coincidentally with SHDN being brought low. When returning to normal operation-from $\overline{\text { SHDN, with an external reference-the }}$ MAX1082/MAX1083 can be considered fully powered up within $2 \mu s$ of actively pulling $\overline{\text { SHDN }}$ high. When using the internal reference, the conversion should be initiated only when the reference has settled; its recovery time is dependent on the external bypass capacitors and the time between conversions.

## Power-Down Sequencing

The MAX1082/MAX1083 auto power-down modes can save considerable power when operating at less than maximum sample rates. Figures 9 and 10 show the average supply current as a function of the sampling rate. The following sections discuss the various powerdown sequences. Other combinations of clock rates and power-down modes may attain the lowest power consumption in other applications.

## Using Full Power-Down Mode

Full power-down mode (FULLPD) achieves the lowest power consumption, up to 1000 conversions per channel per second. Figure 9a shows the MAX1083's power consumption for one- or four-channel conversions utilizing full power-down mode (PD1 = PD0 $=0$ ), with the internal reference and conversion controlled at the maximum clock speed. A $0.01 \mu \mathrm{~F}$ bypass capacitor at REFADJ forms an RC filter with the internal $17 \mathrm{k} \Omega$ reference resistor, with a $170 \mu$ s time constant. To achieve full 10-bit accuracy, seven time constants or 1.2 ms are required after power-up if the bypass capacitor is fully discharged between conversions. Waiting this 1.2 ms duration in fast power-down (FASTPD) or reducedpower (REDP) mode instead of in full power-up can further reduce power consumption. This is achieved by using the sequence shown in Figure 11a.
Figure 9b shows the MAX1083's power consumption for one- or four-channel conversions utilizing FULLPD

## MAX1082/MAX1083

## 300ksps/400ksps, Single-Supply, 4-Channel, Serial 10-Bit ADCs with Internal Reference



Figure 6. Detailed Serial-Interface Timing
mode (PD1 $=$ PD0 $=0$ ), with an external reference and conversion controlled at the maximum clock speed. One dummy conversion to power up the device is needed, but no waiting time is necessary to start the second conversion, thereby achieving lower power consumption at up to half the full sampling rate.

## Using Fast Power-Down and Reduced Power Modes

FASTPD and REDP modes achieve the lowest power consumption at speeds close to the maximum sampling rate. Figure 10 shows the MAX1083's power consumption in FASTPD mode (PD1 = 0, PD0 = 1), REDP mode (PD1 = 1, PD0 = 0), and, for comparison, normal operating mode (PD1 = 1, PD0 = 1). The figure shows power consumption using the specified power-down mode, with the internal reference and conversion controlled at the maximum clock speed. The clock speed in FASTPD or REDP should be limited to 4.8 MHz for the MAX1082/MAX1083. FULLPD mode may provide increased power savings in applications where the MAX1082/MAX1083 are inactive for long periods of time, but intermittent bursts of high-speed conversions are required.

Internal and External References
The MAX1082/MAX1083 can be used with an internal or external reference voltage. An external reference can be connected directly at REF or at the REFADJ pin.
An internal buffer is designed to provide 2.5 V at REF for the MAX1082/MAX1083. The internally trimmed 1.22 V reference is buffered with a 2.05 gain.

## Internal Reference

The MAX1082/MAX1083's full-scale range with the internal reference is 2.5 V with unipolar inputs and $\pm 1.25 \mathrm{~V}$ with bipolar inputs. The internal reference voltage is adjustable by $\pm 100 \mathrm{mV}$ with the circuit in Figure 12.

## External Reference

The MAX1082/MAX1083's external reference can be placed at the input (REFADJ) or the output (REF) of the internal reference-buffer amplifier. The REFADJ input impedance is typically $17 \mathrm{k} \Omega$. At REF, the DC input resistance is a minimum of $18 \mathrm{k} \Omega$. During conversion, an external reference at REF must deliver up to $350 \mu \mathrm{~A}$ DC load current and have $10 \Omega$ or less output impedance. If the reference has a higher output impedance or is noisy, bypass it close to the REF pin with a $4.7 \mu \mathrm{~F}$ capacitor.
To use the direct REF input, disable the internal buffer by connecting REFADJ to VDD1. Using the REFADJ input makes buffering the external reference unnecessary.

Transfer Function
Table 5 shows the full-scale voltage ranges for unipolar and bipolar modes.
Figure 13 depicts the nominal, unipolar input/output (I/O) transfer function, and Figure 14 shows the bipolar I/O transfer function. Code transitions occur halfway between successive-integer LSB values. Output coding is binary, with $1 \mathrm{LSB}=2.44 \mathrm{mV}(2.500 \mathrm{~V} / 2 / 1024)$ for

## 300ksps/400ksps, Single-Supply, 4-Channel,

 Serial 10-Bit ADCs with Internal Reference

Figure 7. Continuous 16-Clock/Conversion Timing


Figure 8. Reference Power-Up Delay vs. Time in Shutdown


Figure 9a. Average Supply Current vs. Conversion Rate with Internal Reference in FULLPD


Figure 9b. Average Supply Current vs. Conversion Rate with External Reference in FULLPD


Figure 10. Average Supply Current vs. Sampling Rate (in FASTPD, REDP, and Normal Operation)

## MAX1082/MAX1083

## 300ksps/400ksps, Single-Supply, 4-Channel, Serial 10-Bit ADCs with Internal Reference

unipolar operation, and 1LSB $=2.44 \mathrm{mV}[(2.500 \mathrm{~V} / 2) /$ 1024] for bipolar operation.

## Layout, Grounding, and Bypassing

For best performance, use printed circuit (PC) boards; wire-wrap boards are not recommended. Board layout should ensure that digital and analog signal lines are separated from each other. Do not run analog and digital (especially clock) lines parallel to one another, or digital lines underneath the ADC package.
Figure 15 shows the recommended system ground connections. Establish a single-point analog ground (star ground point) at GND. Connect all other analog grounds to the star ground. Connect the digital system ground to this ground only at this point. For lowestnoise operation, the ground return to the star ground's power supply should be low impedance and as short as possible.
High-frequency noise in the VDD1 power supply may affect the high-speed comparator in the ADC. Bypass the supply to the star ground with $0.1 \mu \mathrm{~F}$ and $10 \mu \mathrm{~F}$
capacitors close to VDD1 of the MAX1082/MAX1083. Minimize capacitor lead lengths for best supply-noise rejection. If the power supply is very noisy, a $10 \Omega$ resistor can be connected as a lowpass filter (Figure 15).

## High-Speed Digital Interfacing with QSPI

The MAX1082/MAX1083 can interface with QSPI using the circuit in Figure $16(C P O L=0, C P H A=0)$. This QSPI circuit can be programmed to do a conversion on each of the four channels. The result is stored in memory without taxing the CPU, since QSPI incorporates its own microsequencer.

TMS320LC3x Interface
Figure 17 shows an application circuit to interface the MAX1082/MAX1083 to the TMS320 in external clock mode. The timing diagram for this interface circuit is shown in Figure 18.
Use the following steps to initiate a conversion in the MAX1082/MAX1083 and to read the results:

1) The TMS320 should be configured with CLKX (transmit clock) as an active-high output clock and


Figure 11a. Full Power-Down Timing


Figure 11b. FASTPD and REDP Timing

## 300ksps/400ksps, Single-Supply, 4-Channel, Serial 10-Bit ADCs with Internal Reference



Figure 12. MAX1082/MAX1083 Reference-Adjust Circuit


Figure 13. Unipolar Transfer Function, Full Scale (FS) $=$ VREF $+V_{C O M}$, Zero Scale (ZS) $=$ VCOM

CLKR (TMS320 receive clock) as an active-high input clock. CLKX and CLKR on the TMS320 are connected to the MAX1082/MAX1083's SCLK input.
2) The MAX1082/MAX1083's $\overline{\mathrm{CS}}$ pin is driven low by the TMS320's XF_ I/O port to enable data to be clocked into the MAX1082/MAX1083's DIN pin.
3) An 8-bit word (1XXXXX11) should be written to the MAX1082/MAX1083 to initiate a conversion and place the device into normal operating mode. See Table 3 to select the proper XXXXX bit values for your specific application.
4) The MAX1082/MAX1083's SSTRB output is monitored through the TMS320's FSR input. A falling edge on the SSTRB output indicates that the conversion is in progress and data is ready to be received from the device.


Figure 14. Bipolar Transfer Function, Full Scale (FS) = $V_{\text {REF }} / 2+V_{C O M}$, Zero Scale $(Z S)=V_{C O M}$
5) The TMS320 reads in 1 data bit on each of the next 16 rising edges of SCLK. These data bits represent the $10+2$-bit conversion result followed by 4 trailing bits, which should be ignored.
6) Pull $\overline{\mathrm{CS}}$ high to disable the MAX1082/MAX1083 until the next conversion is initiated.

## Definitions

## Integral Nonlinearity

Integral nonlinearity (INL) is the deviation of the values from a straight line on an actual transfer function. This straight line can be a best-straight-line fit or a line drawn between the endpoints of the transfer function, once offset and gain errors have been nullified. The static linearity parameters for the MAX1082/MAX1083 are measured using the best straight-line fit method.

Differential Nonlinearity
Differential nonlinearity (DNL) is the difference between an actual step width and the ideal value of 1LSB. A DNL error specification of less than 1LSB guarantees no missing codes and a monotonic transfer function.

## Aperture Width

Aperture width (tAW) is the time the T/H circuit requires to disconnect the hold capacitor from the input circuit (for instance, to turn off the sampling bridge, and put the $\mathrm{T} / \mathrm{H}$ unit in hold mode).

## MAX1082/MAX1083

## 300ksps/400ksps, Single-Supply, 4-Channel, Serial 10-Bit ADCs with Internal Reference

## Table 5. Full Scale and Zero Scale

| UNIPOLAR MODE |  | BIPOLAR MODE |  |  |
| :---: | :---: | :---: | :---: | :---: |
| Full Scale | Zero Scale | Positive <br> Full Scale | Zero <br> Scale | Negative <br> Full Scale |
| VREF + VCOM | VCOM | $V_{\text {REF }} / 2$ <br> $+V_{\text {COM }}$ | VCOM | $-V_{\text {REF }} / 2$ <br> $+V_{\text {COM }}$ |



Figure 15. Power-Supply Grounding Connection

## Aperture Jitter

Aperture jitter (tAJ) is the sample-to-sample variation in the time between the samples.

## Aperture Delay

Aperture delay ( $t_{A D}$ ) is the time defined between the rising edge of the sampling clock and the instant when an actual sample is taken.

Signal-to-Noise Ratio (SNR)
For a waveform perfectly reconstructed from digital samples, the SNR is the ratio of the full-scale analog input (RMS value) to the RMS quantization error (residual error). The ideal, theoretical minimum analog-to-digital noise is caused only by quantization error and results directly from the ADC's resolution ( N bits):

$$
\text { SNR }=(6.02 \times N+1.76) \mathrm{dB}
$$

In reality, there are other noise sources besides quantization noise, including thermal noise, reference noise,
clock jitter, etc. Therefore, SNR is calculated by taking the ratio of the RMS signal to the RMS noise, which includes all spectral components minus the fundamental, the first five harmonics, and the DC offset.

Signal-to-Noise Plus Distortion (SINAD) SINAD is the ratio of the fundamental input frequency's RMS amplitude to RMS equivalent of all other ADC output signals:

$$
\text { SINAD (dB) = } 20 \times \log (\text { SignalRMS / Noiserms) }
$$

Effective Number of Bits (ENOB) ENOB indicates the global accuracy of an ADC at a specific input frequency and sampling rate. An ideal ADC's error consists only of quantization noise. With an input range equal to the ADC's full-scale range, calculate ENOB as follows:

$$
\text { ENOB = (SINAD - 1.76) / } 6.02
$$

Total Harmonic Distortion (THD)
THD is the ratio of the RMS sum of the input signal's first five harmonics to the fundamental itself. This is expressed as:

$$
T H D=20 \times \log \frac{\left(\sqrt{V_{2}^{2}+V_{3}^{2}+V_{4}^{2}+V_{4}^{2}+V_{5}^{2}}\right)}{V_{1}}
$$

where $\mathrm{V}_{1}$ is the fundamental amplitude, and $\mathrm{V}_{2}$ through V5 are the amplitudes of the 2nd- through 5th-order harmonics.

## Spurious-Free Dynamic Range (SFDR)

SFDR is the ratio of the RMS amplitude of the fundamental (maximum signal component) to the RMS value of the next-largest distortion component.

## MAX1082/MAX1083

300ksps/400ksps, Single-Supply, 4-Channel, Serial 10-Bit ADCs with Internal Reference


Figure 16. QSPI Connections, External Reference


Figure 17. MAX1082/MAX1083-to-TMS320 Serial Interface

## MAX1082/MAX1083

## 300ksps/400ksps, Single-Supply, 4-Channel, Serial 10-Bit ADCs with Internal Reference



Figure 18. MAX1082/MAX1083-to-TMS320 Serial Interface

Typical Operating Circuit


Ordering Information (continued)

| PART | TEMP RANGE | PIN- <br> PACKAGE | INL <br> (LSB) |
| :--- | :---: | :---: | :---: |
| MAX1083ACUE + | $0^{\circ} \mathrm{C}$ to $+70^{\circ} \mathrm{C}$ | 16 TSSOP | $\pm 1 / 2$ |
| MAX1083BCUE + | $0^{\circ} \mathrm{C}$ to $+70^{\circ} \mathrm{C}$ | 16 TSSOP | $\pm 1$ |
| MAX1083AEUE + | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ | 16 TSSOP | $\pm 1 / 2$ |
| MAX1083BEUE + | $-40^{\circ} \mathrm{C}$ to $+85^{\circ} \mathrm{C}$ | 16 TSSOP | $\pm 1$ |

+Denotes a lead(Pb)-free/RoHS-compliant package
$\qquad$
Chip Information
PROCESS: BiCMOS

## Package Information

For the latest package outline information and land patterns (footprints), go to www.maximintegrated.com/packages. Note that a "+", "\#", or "-" in the package code indicates RoHS status only. Package drawings may show a different suffix character, but the drawing pertains to the package regardless of RoHS status.

| PACKAGE TYPE | PACKAGE CODE | OUTLINE NO. | LAND PATTERN NO. |
| :---: | :---: | :---: | :---: |
| 16 TSSOP | U16+1 | 21-0066 | 90-0117 |

Revision History

| REVISION <br> NUMBER | REVISION <br> DATE | DESCRIPTION | PAGES <br> CHANGED |
| :---: | :---: | :--- | :---: |
| 0 | $5 / 00$ | Initial release | - |
| 1 | $9 / 12$ | Added lead-free notation to Ordering Information. | 1 |
| 2 | $12 / 14$ | Corrected Absolute Maximum Ratings | 2 |

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